

N-Channel 650V (D-S) Power MOSFET

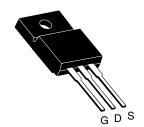
PRODUCT SUMMARY				
V _{DS} (V)	650			
R _{DS(on)} max. at 25 °C (Ω)	V _{GS} = 10 V 0.17			
Q _g max. (nC)	109			
Q _{gs} (nC)	15			
Q _{gd} (nC)	31			
Configuration	Single			

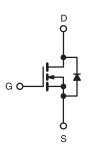
FEATURES

- Low figure-of-merit (FOM) Ron x Qg
- Low input capacitance (Ciss)
- Reduced switching and conduction losses
- Ultra low gate charge (Qg)
- Avalanche energy rated (UIS)



TO-220 FULLPAK





N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	650	V	
Gate-Source Voltage			V_{GS}	± 30	V	
Continuous Drain Current (T. 150 °C)	V _{GS} at 10 V	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$	- I _D	20	А	
Continuous Drain Current (T _J = 150 °C)		T _C = 100 °C		13		
Pulsed Drain Current ^a			I _{DM}	56	İ	
Linear Derating Factor				1.8	W/°C	
Single Pulse Avalanche Energy b			E _{AS}	691	mJ	
Maximum Power Dissipation			P _D	30	W	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +150	°C	
Drain-Source Voltage Slope T _J = 125 °C		dV/dt	70	- V/ns		
Reverse Diode dV/dt ^d			26			
Soldering Recommendations (Peak Temperature) c for 10 s			300	°C		

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature.
- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 28.2 mH, R_g = 25 Ω , I_{AS} = 7 A.
- c. 1.6 mm from case.
- d. $I_{SD} \le I_D$, dI/dt = 100 A/ μ s, starting $T_J = 25$ °C.



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	65	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	3.6	C/VV	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static		-					
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	= 0 V, I _D = 250 μA	650	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I _D = 1 mA		0.74	-	V/°C
Gate-Source Threshold Voltage (N)	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	3	-	5	V
	_	V _{GS} = ± 20 V		-	-	± 100	nA
Gate-Source Leakage	I _{GSS}	$V_{GS} = \pm 30 \text{ V}$		-	-	± 1	μΑ
Zava Cata Valtaga Dvain Cuwant	$V_{DS} = 650 \text{ V}, V_{GS} = 0 \text{ V}$		= 650 V, V _{GS} = 0 V	-	-	1	μ.Λ
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 520 \	/, V _{GS} = 0 V, T _J = 125 °C	-	-	10	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 11 A	-	0.170	-	Ω
Forward Transconductance	9 _{fs}	V _D	_S = 8 V, I _D = 5 A	-	6.7	-	S
Dynamic					•		
Input Capacitance	C _{iss}		$V_{GS} = 0 V$,	-	2414	-	_
Output Capacitance	C _{oss}	1	$V_{DS} = 100 \text{ V},$	-	118	_	
Reverse Transfer Capacitance	C _{rss}	7	f = 1 MHz		4	-	pF
Effective Output Capacitance, Energy Related ^a	C _{o(er)}			-	89	-	
Effective Output Capacitance, Time Related ^b	C _{o(tr)}	V _{DS} = 0 \	$V_{DS} = 0 \text{ V to } 520 \text{ V}, V_{GS} = 0 \text{ V}$		307	-	
Total Gate Charge	Qg			-	73	110	1
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$V_{GS} = 10 \text{ V}$ $I_{D} = 11 \text{ A}, V_{DS} = 520 \text{ V}$		15	-	nC
Gate-Drain Charge	Q _{gd}	1 1		-	32	-	
Turn-On Delay Time	t _{d(on)}	V _{DD} = 520 V, I _D = 11 A,		-	22	45	
Rise Time	t _r			-	33	66	
Turn-Off Delay Time	t _{d(off)}	V _{GS} =	= 10 V, $R_g = 9.1 \Omega$	-	73	110	ns
Fall Time	t _f	1	1		38	76	1
Gate Input Resistance	R_g	f = 1 MHz, open drain		-	0.64	-	Ω
Drain-Source Body Diode Characteristic	s						•
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	22	,
Pulsed Diode Forward Current	I _{SM}			-	-	56	- A
Diode Forward Voltage	V _{SD}	T _J = 25 °C, I _S = 11 A, V _{GS} = 0 V		-	-	1.2	V
Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = I _S = 11 A, dl/dt = 100 A/μs, V _R = 400 V		-	400	-	ns
Reverse Recovery Charge	Q _{rr}			-	5.9	-	μC
Reverse Recovery Current	I _{RRM}			_	20	-	A

- a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

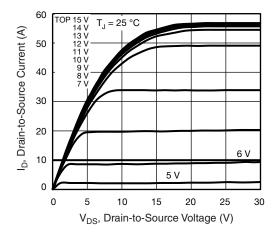


Fig. 1 - Typical Output Characteristics

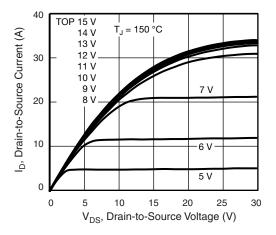


Fig. 2 - Typical Output Characteristics

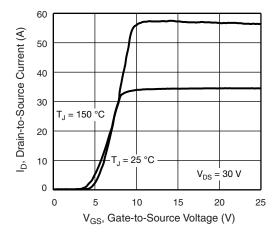


Fig. 3 - Typical Transfer Characteristics

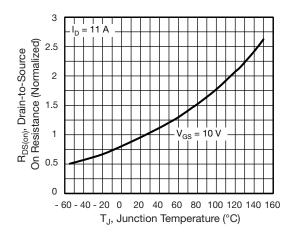


Fig. 4 - Normalized On-Resistance vs. Temperature

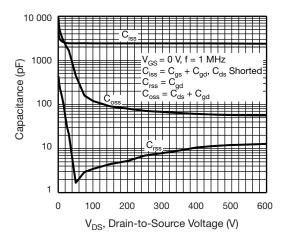


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

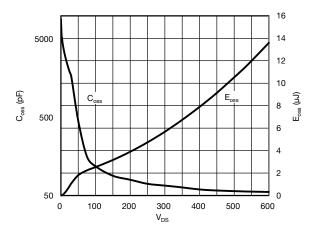


Fig. 6 - C_{oss} and E_{oss} vs. V_{DS}



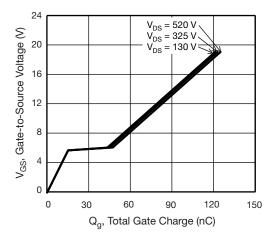


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

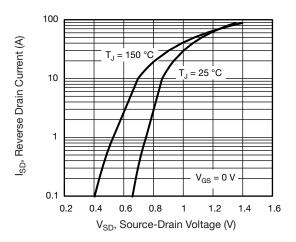


Fig. 8 - Typical Source-Drain Diode Forward Voltage

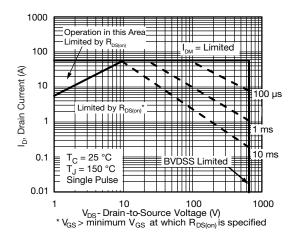


Fig. 9 - Maximum Safe Operating Area

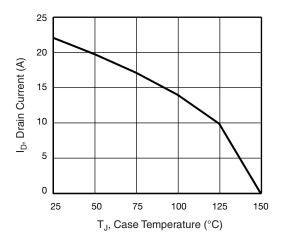


Fig. 10 - Maximum Drain Current vs. Case Temperature

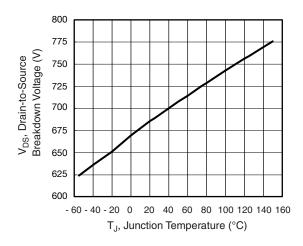


Fig. 11 - Temperature vs. Drain-to-Source Voltage



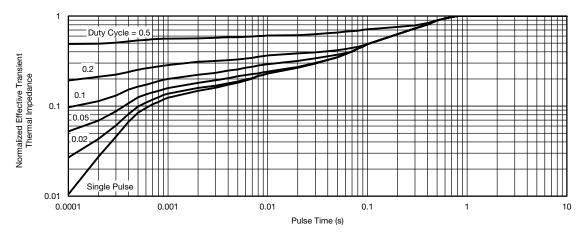


Fig. 12 - Normalized Thermal Transient Impedance, Junction-to-Case

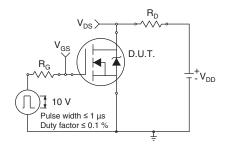


Fig. 13 - Switching Time Test Circuit

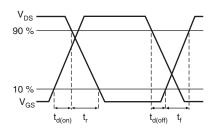


Fig. 14 - Switching Time Waveforms

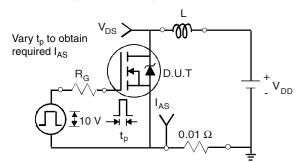


Fig. 15 - Unclamped Inductive Test Circuit

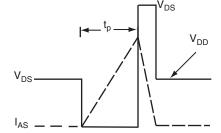


Fig. 16 - Unclamped Inductive Waveforms

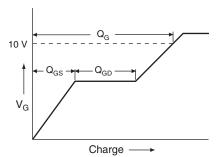


Fig. 17 - Basic Gate Charge Waveform

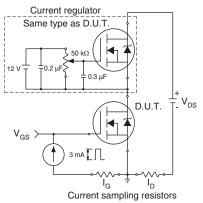
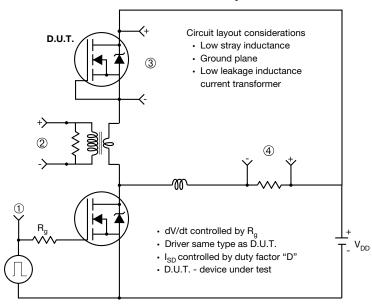


Fig. 18 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



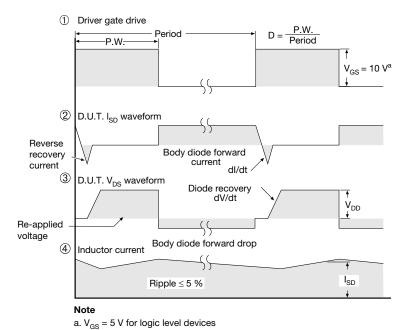
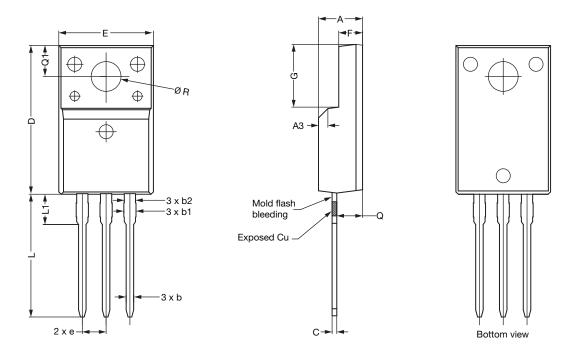


Fig. 19 - For N-Channel



TO-220 FULLPAK



	MILLIMETERS			
DIM.	MIN.	NOM.	MAX.	
А	4.60	4.70	4.80	
b	0.70	0.80	0.91	
b1	1.20	1.30	1.47	
b2	1.10	1.20	1.30	
С	0.45	0.50	0.63	
D	15.80	15.87	15.97	
е		2.54 BSC		
E	10.00	10.10	10.30	
F	2.44	2.54	2.64	
G	6.50	6.70	6.90	
L	12.90	13.10	13.30	
L1	3.13	3.23	3.33	
Q	2.65	2.75	2.85	
Q1	3.20	3.30	3.40	
ØR	3.08	3.18	3.28	

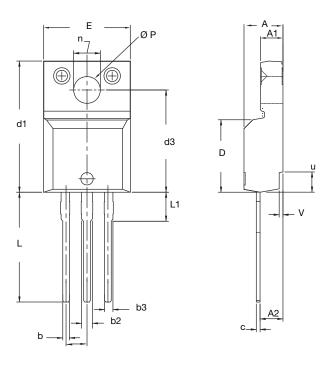
Notes

- 1. To be used only for process drawing 2. These dimensions apply to all TO-220 FULLPAK leadframe versions 3 leads 3. All critical dimensions should C meet $C_{\rm pk} > 1.33$ 4. All dimensions include burrs and plating thickness

- 5. No chipping or package damage
 6. Facility code will be the 1st character located at the 2nd row of the unit marking



FACILITY



	MILLIMETERS		INCHES	
DIM.	MIN.	MAX.	MIN.	MAX.
А	4.570	4.830	0.180	0.190
A1	2.570	2.830	0.101	0.111
A2	2.510	2.850	0.099	0.112
b	0.622	0.890	0.024	0.035
b2	1.229	1.400	0.048	0.055
b3	1.229	1.400	0.048	0.055
С	0.440	0.629	0.017	0.025
D	8.650	9.800	0.341	0.386
d1	15.88	16.120	0.622	0.635
d3	12.300	12.920	0.484	0.509
Е	10.360	10.630	0.408	0.419
е	2.54	2.54 BSC		BSC
L	13.200	13.730	0.520	0.541
L1	3.100	3.500	0.122	0.138
n	6.050	6.150	0.238	0.242
ØP	3.050	3.450	0.120	0.136
u	2.400	2.500	0.094	0.098
V	0.400	0.500	0.016	0.020
ECN: E10 0190 Pay D (08 Apr 2010			

ECN: E19-0180-Rev. D, 08-Apr-2019

DWG: 5972

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